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I. Introduction				View More		
II Sensor	Abstract: Core diameter mismatch struc	ures are proposed and experime	entally			
Fabrication	investigated for curvature and vibration s approach uses a View more	ensing. Two configurations are su	uggested, one	See the top organizations		
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Analysis	Abstract:					
IV. Results and	Core diameter mismatch structures are p	ORGANIZATION 3				
	a structure formed by splicing an uncoate	ORGANIZATION 2				
V. Conclusion	V. Conclusion standard single-mode fibers (SMFs) single-mode-multimode-single-mode (SMS),					
Authors	combined to a fiber optical mirror at its er made by splicing a section of SMF betwe	Click to Expand				
Figures	curvature analysis, the proposed SMS se	nsor generates the destructive in	iterference			
riguics	patterns when it is bent, varying only the wavelength shifts. The SMSMS vibration	Provided by: POWERTO BY IEEE AND IP.COM A PATENT SEARCH AND ANALYTICS TOOL				
References	low frequencies such as 0.1 Hz. The con	iguration of the proposed sensor	s presents			
Citations	several interesting features, such as easy sensitivity. These advantages make such applications for instance, structural healt	Advertisement				
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I. Introduction

Recent advances and cost reductions in optical devices have stimulated the interest in optical fiber sensors applied to measure the physical and mechanical parameters, mainly because of potential applications in several fields, for instance, structural health monitoring (SBity) [fi]te(3)continue described intermeters are crucial for identification, localization, and other parameters are crucial for identification, localization, and quantification of structural damages, and also improve the maintenance and safety of the monitored structures [4]–[7].

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